

# Synthesis of Two-Dimensional Nb<sub>1.33</sub>C (MXene) with Randomly Distributed Vacancies by Etching of the Quaternary Solid Solution (Nb<sub>2/3</sub>Sc<sub>1/3</sub>)<sub>2</sub>AlC MAX Phase

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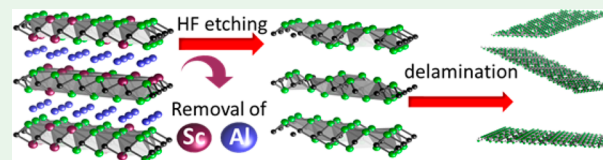
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## Supporting Information

**ABSTRACT:** Introducing point defects in two-dimensional (2D) materials can alter or enhance their properties. Here, we demonstrate how etching a laminated (Nb<sub>2/3</sub>Sc<sub>1/3</sub>)<sub>2</sub>AlC MAX phase (solid solution) of both the Sc and Al atoms results in a 2D Nb<sub>1.33</sub>C material (MXene) with a large number of vacancies and vacancy clusters. This method is applicable to any quaternary, or higher, MAX phase, wherein one of the transition metals is more reactive than the other and could be of vital importance in applications such as catalysis and energy storage. We also report, for the first time, on the existence of solid solution (Nb<sub>2/3</sub>Sc<sub>1/3</sub>)<sub>3</sub>AlC<sub>2</sub> and (Nb<sub>2/3</sub>Sc<sub>1/3</sub>)<sub>4</sub>AlC<sub>3</sub> phases.

**KEYWORDS:** transition-metal carbide, 2D material, synthesis, MXene, electronic properties



Two-dimensional (2D) materials have shown great promise for many applications.<sup>1–6</sup> The reduced dimension leads to an increase in the surface-to-volume ratio and can fundamentally alter the chemical, optical, and electronic properties of a material. The properties can be altered further, either chemically via surface functionalization<sup>7</sup> and intercalation<sup>8</sup> or structurally by the introduction of defects.<sup>8,9</sup>

About 7 years ago, a new class of 2D materials based on transition-metal carbides and/or nitrides (MXenes) was discovered.<sup>10,11</sup> MXenes are mainly produced by etching the M<sub>n+1</sub>AX<sub>n</sub> (MAX) phases or related ternary phases.<sup>12</sup> The MAX phases are a family of hexagonal, layered ternary transition-metal carbides and/or nitrides where M stands for an early transition metal, A stands mostly for group 13 and 14 elements, X stands for carbon and/or nitrogen, and n = 1, 2, or 3.<sup>13</sup> Various acidic solutions containing fluorine ions are used to selectively etch the A layers (either Al or Ga) and convert MAX to MXene.<sup>10,14–17</sup> The A layers are replaced with oxygen, hydroxyl, and/or fluorine surface-terminating (T) groups.<sup>18</sup> MXenes show promise for a large host of applications including batteries, supercapacitors, transparent conducting electrodes, catalytic and photocatalytic applications, water treatment, electromagnetic shielding, gas sensors, and biosensors.<sup>19–25</sup>

MXene properties can be tuned in at least three ways, which involve altering their (i) composition, (ii) surface terminations, T<sub>x</sub>, and/or, (iii) structure/morphology. The composition can be changed by, e.g., forming solid solutions, though alloying on the M<sub>26</sub> and/or X<sup>27</sup> sites in the parent MAX phase. The quaternaries (Nb<sub>0.8</sub>Ti<sub>0.2</sub>)<sub>4</sub>C<sub>3</sub>T<sub>x</sub> and (Nb<sub>0.8</sub>Zr<sub>0.2</sub>)<sub>4</sub>C<sub>3</sub>T<sub>x</sub><sup>28</sup> are examples in which M-site MAX solid-solution phases were

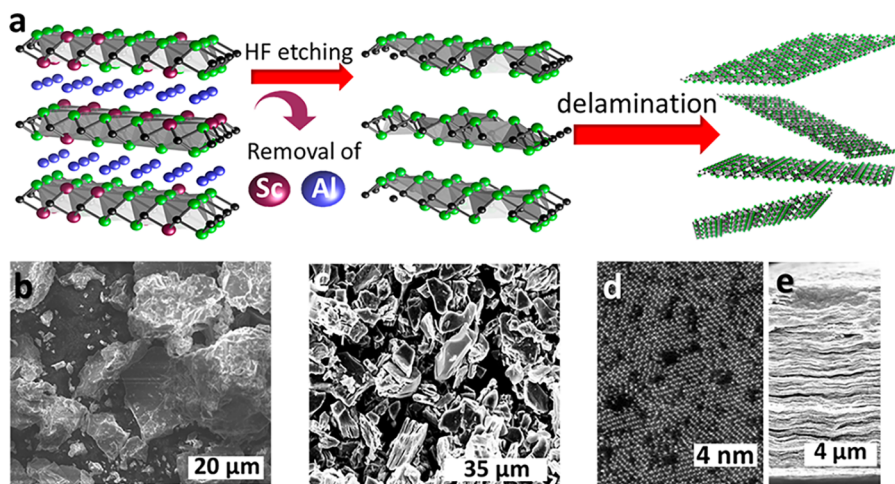
etched to produce their MXenes. Ti<sub>3</sub>CNT<sub>x</sub> is an example of a MXene with an X-site solid solution.<sup>11</sup> Altering the surface terminations can be accomplished by chemical treatment such as alkali treatment and/or postetching heat treatment to remove fluorine terminations.<sup>29,30</sup>

Quite recently, quaternary n = 1, or 211, MAX phases with in-plane chemical ordering were discovered. These phases were labeled *i*-MAX because of the ordering of two different M elements, in a 2:1 ratio, in the basal planes. The first example was (Mo<sub>2/3</sub>Sc<sub>1/3</sub>)<sub>2</sub>AlC.<sup>31</sup> When this phase was etched, both the Al and Sc atoms were removed and a MXene—Mo<sub>1.33</sub>CT<sub>x</sub> wherein the vacancies were ordered—was produced. This vacancy-ordered 2D material exhibited a 3 orders of magnitude higher electrical conductivity and a 65% higher capacitance when used as a supercapacitor electrode compared to Mo<sub>2</sub>CT<sub>x</sub>. Furthermore, an ultrathin flexible Mo<sub>1.33</sub>CT<sub>x</sub>/polymer film showed promising performance as a solid-state supercapacitor.<sup>32</sup> Since then, other *i*-MAX phases have been theoretically predicted and synthesized such as (V<sub>2/3</sub>Zr<sub>1/3</sub>)<sub>2</sub>AlC, (Mo<sub>2/3</sub>Y<sub>1/3</sub>)<sub>2</sub>AlC, and (Cr<sub>2/3</sub>Sc<sub>1/3</sub>)<sub>2</sub>AlC.<sup>33,34</sup> A characteristic feature of the *i*-MAX phase is that the minority M elements extend from the M toward the Al layers, with a structure described by C2/c or C2/m symmetry.<sup>32</sup> This is opposed to the traditional MAX phase of P6<sub>3</sub>/mmc symmetry, which describes most of the solid solution quaternary 211 MAX phases realized.

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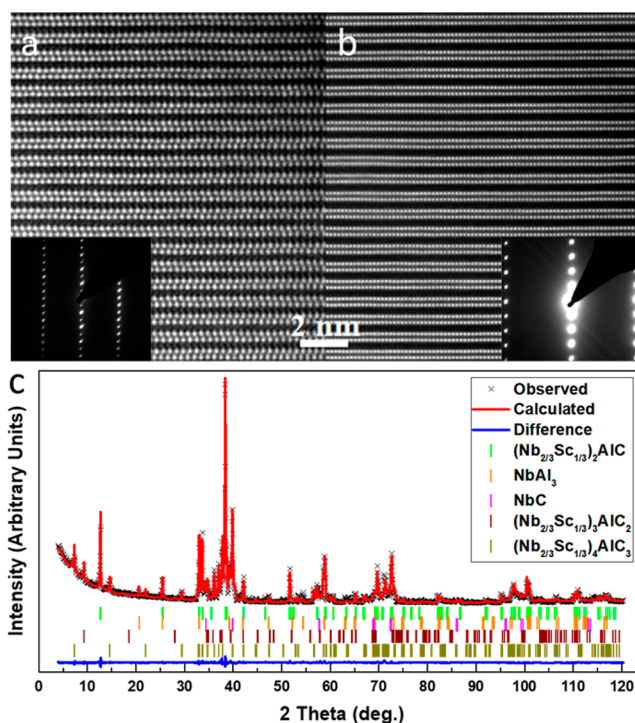
**Figure 1.** (a) Schematic of the synthesis, etching, and delamination of  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_2\text{AlC}$  to form  $\text{Nb}_{1.33}\text{CT}_x$ . Green, black, red, and blue represent Nb, C, Sc, and Al atoms, respectively. (b) SEM micrograph of  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_2\text{AlC}$  powders. (c) SEM micrograph of multilayered  $\text{Nb}_{1.33}\text{CT}_x$  powders. (d) STEM micrograph of a single  $\text{Nb}_{1.33}\text{CT}_x$  flake, (e) SEM micrograph of the cross section of a free-standing film made from d- $\text{Nb}_{1.33}\text{CT}_x$ .

A large majority of MXene work to date has been carried out on  $\text{Ti}_3\text{C}_2\text{T}_x$ . There are others, however. Recently,  $\text{Nb}_2\text{CT}_x$  flakes have shown promising performance for photothermal cell ablation and as a photocatalyst for hydrogen evolution in addition to previously reported results for energy storage applications.<sup>35–38</sup> These reports were the impetus for this work, together with our recent discovery of a quaternary *i*-MAX phase in which the minority M element, Sc in this case, was readily etched.

First, we synthesized the new quaternary MAX solid solution,  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_2\text{AlC}$ , wherein the M elements Nb and Sc are not ordered. We then selectively etched both Al and Sc atoms to produce  $\text{Nb}_{1.33}\text{CT}_x$  with randomly distributed vacancies and vacancy clusters. A schematic of our approach is shown in Figure 1a. In principle, this method should be applicable to any quaternary MAX phase in which the minority M element is etchable.

The quaternary solid solution  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_2\text{AlC}$  was synthesized by reacting the elemental powders Nb, Sc, Al, and, C in a molar ratio of  $4/3:2/3:1:1$  at  $1400\text{ }^\circ\text{C}$  for 2 h in flowing Ar (processing details can be found in the Supporting Information). The crystal structure is shown in the leftmost panel in Figure 1a. Parts b and c of Figure 1 show scanning electron microscopy (SEM) images of the  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_2\text{AlC}$  powders before and after etching, respectively. Figure 1d shows a typical scanning transmission electron microscopy (STEM) image of a single  $\text{Nb}_{1.33}\text{CT}_x$  flake showing vacancies and vacancy clusters. The removal of Sc atoms was confirmed by electron energy loss spectroscopy analysis (see Figure S1). Figure 1e shows a cross-sectional SEM image of a free-standing thin film made by filtering delaminated (d)- $\text{Nb}_{1.33}\text{CT}_x$  flakes.

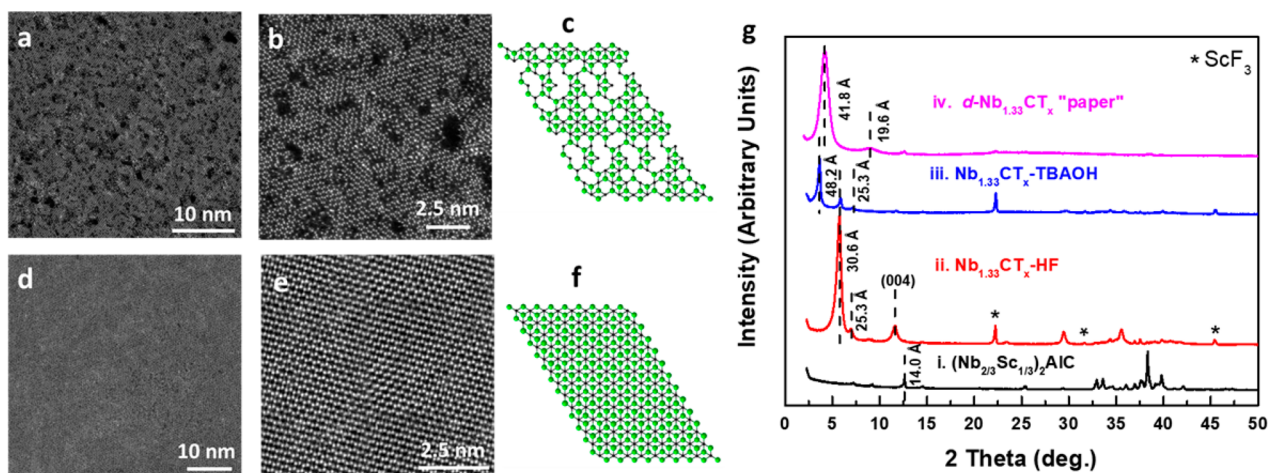
The STEM images, shown in Figure 2a,b, show the typical MAX-phase-layered structure.<sup>13</sup> The MAX-phase identification is further confirmed by selected-area electron diffraction (SAED; Figure 2a,b, insets). Rietveld refinement analysis of a powder X-ray diffraction (XRD) pattern (Figure 2c) was used to quantify the various phases present. According to Rietveld analysis (refinement details can be found in the Supporting Information), the sample contained the following phases:  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_2\text{AlC}$ ,  $\text{NbAl}_3$ ,  $\text{NbC}$ ,  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_3\text{AlC}_2$ , and  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_4\text{AlC}_3$  with weight percentages of 68(2), 10.1(4), 17.4(4), 2.5(3), and 2.0(2) wt %, respectively. When all of the



**Figure 2.** (a) STEM micrograph with SAED of  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_2\text{AlC}$  in the  $[11\bar{2}0]$  zone axis. (b) Same as part a but in the  $[10\bar{1}0]$  zone axes. (c) XRD patterns indexed to a  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_2\text{AlC}$  powder showing the observed pattern (black crosses), the Rietveld-generated pattern (red line), and the difference between the two (blue line). The green, orange, purple, violet, and olive ticks below the pattern represent the peak positions of  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_2\text{AlC}$ ,  $\text{NbAl}_3$ ,  $\text{NbC}$ ,  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_3\text{AlC}_2$ , and  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_4\text{AlC}_3$  phases, respectively.

phases were considered, the  $\chi^2$  value was 8.78. Note that the powder showed evidence for  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_{n+1}\text{AlC}_n$  with  $n = 1–3$ .

For the main phase  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_2\text{AlC}$ , because Nb and Sc are randomly distributed in the transition-metal position, the quaternary MAX phase retains the  $P6_3/mmc$  symmetry of the ternary MAX phases. The  $a$  and  $c$  lattice parameters were calculated to be  $3.12915(5)$  and  $13.9736(3)$  Å, respectively, which agree with those obtained from STEM and SAED. These



**Figure 3.** (a) Low-magnification STEM micrograph of a  $\text{Nb}_{1.33}\text{CT}_x$  single flake. (b) Same as panel (a) but at higher magnification. (c) Top-view schematic of a single  $\text{Nb}_{1.33}\text{CT}_x$  sheet showing random vacancies and vacancy clusters. (d) Low-magnification STEM micrograph of a  $\text{Nb}_2\text{CT}_x$  single flake. (e) Same as panel (d) but at higher magnification. (f) Top-view schematic of a single  $\text{Nb}_2\text{CT}_x$  sheet. (g) XRD patterns of (i)  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_2\text{AlC}$ , (ii)  $\text{Nb}_{1.33}\text{CT}_x\text{-HF}$ , which is that of MLs after HF etching of  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_2\text{AlC}$  powders, (iii)  $\text{Nb}_{1.33}\text{CT}_x\text{-HF-TBAOH}$ , which is  $\text{Nb}_{1.33}\text{CT}_x$  after intercalation with TBAOH, and (iv) a  $\text{d-Nb}_{1.33}\text{CT}_x$  film obtained by filtering a suspension of  $\text{d-Nb}_{1.33}\text{CT}_x$  (Figure 1e). Peaks denoted by asterisks correspond to  $\text{ScF}_3$ , which is a residue of etching.

lattice parameters are slightly larger than those of  $\text{Nb}_2\text{AlC}$  ( $a = 3.096\text{--}3.126$  Å and  $c = 13.804\text{--}13.888$  Å).<sup>39</sup> The difference can be ascribed to the larger metallic radius of Sc (160 pm) compared to Nb (145 pm).<sup>40</sup> Similarly, and likely for the same reason, the lattice parameters of  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_4\text{AlC}_3$  [ $a = 3.1855(5)$  Å and  $c = 23.878(6)$  Å] are slightly larger than those of  $\text{Nb}_4\text{AlC}_3$  ( $a = 3.1296$  Å and  $c = 24.1208$  Å).<sup>41</sup> Despite the fact that to date  $\text{Nb}_3\text{AlC}_2$  has not been experimentally realized, the introduction of Sc appears to stabilize the  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_3\text{AlC}_2$  solid solution. This has also been reported for other 312 phases, where a second M element stabilizes an otherwise unstable 312 phase.<sup>42,43</sup>

According to energy-dispersive X-ray spectroscopy (EDS) of individual MAX-phase particles assumed to be  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_2\text{AlC}$ , the Nb:Sc:Al atomic ratio was 1.2:0.8:1.0 (details of EDS analysis can be found in the Supporting Information). From the Rietveld refinement of the Nb and Sc occupancies in the same phase, the Nb:Sc atomic ratio was found to be 1.38:0.62. It is thus reasonable to conclude that the Nb:Sc ratio is between 1.2:0.8 and 1.4:0.6. At 2:1.33 to 2:0.86, respectively, these ratios bracket the nominal ratio of 2:1.

The MXene synthesis details can be found in the Supporting Information. Immersing  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_2\text{AlC}$  powders in 48% concentrated hydrofluoric acid (HF) at room temperature for 30 h resulted in selective etching of the majority of both of the Al and Sc atoms, creating  $\text{Nb}_{1.33}\text{CT}_x$  multilayers (MLs; Figure 1c). Clearly, the Sc atoms are more reactive than the Nb atoms, which is consistent with theoretical calculations, which have shown that the Sc–C and C–Al bonds in  $\text{Sc}_2\text{AlC}$  are of comparable strength and both weaker than the Nb–C or Nb–Al bonds in  $\text{Nb}_2\text{AlC}$ .<sup>44</sup>

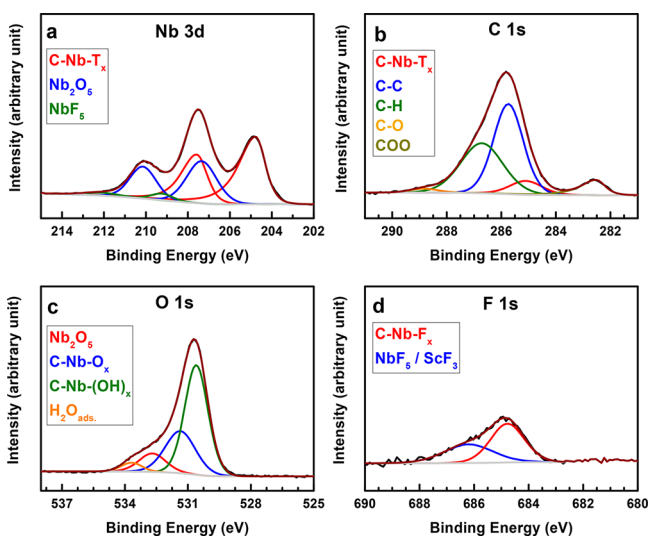
To obtain  $\text{Nb}_{1.33}\text{CT}_x$  monolayers, the ML powder was intercalated with tetrabutylammonium hydroxide (TBAOH) in water following the procedure described by Naguib et al.,<sup>45</sup> followed by delamination in water by hand shaking, yielding a  $\approx 1$  mg/mL suspension of, most probably, single MXene flakes in water. To produce a  $\text{d-Nb}_2\text{CT}_x$  suspension starting with  $\text{Nb}_2\text{AlC}$ , using the same method, the etching time had to be increased to 100 h—compared to 30 h for  $(\text{Nb}_{2/3}\text{Sc}_{1/3})_2\text{AlC}$ —

yielding a colloidal suspension with a concentration of  $<0.5$  mg/mL. Hence, the introduction of Sc in the MAX phase improves the yield and reduces the etching time.

Upon filtering of the  $\text{Nb}_{1.33}\text{CT}_x$  and  $\text{Nb}_2\text{CT}_x$  suspensions, only the former formed flexible, free-standing films that were easy to handle. The latter formed a brittle film that could not be peeled off of the filter membrane without breaking into small pieces. It is for this reason that no transport properties are reported for this compound.

A typical morphology of a  $\text{Nb}_{1.33}\text{CT}_x$  single flake can be seen in the STEM images in Figure 3a,b and can be compared to the schematic shown in Figure 3c. The flakes contain vacancies and vacancy clusters ranging in size between 0.1 and 2 nm, resulting from removal of the Sc atoms. The vacancies' areal coverage varied from 20% to 35% depending on the area imaged (see Figure S2). STEM images of  $\text{Nb}_2\text{CT}_x$  single flakes, on the other hand, are shown in Figure 3d,e. In this case, the MXene layers, shown schematically in Figure 3f, are quite visibly less defective. The XRD patterns of the etched material (Figure 3g) show the typical increase in the interlayer spacing, denoted as  $d_{c/2}$  [because it is  $1/2$  the  $c$ -LP of the (002) parent MAX], to that of the parent phase [compare parts g(i) and g(ii) of Figure 3]. This is typical of the MAX-to-MXene conversion and reflects the substitution of Al with surface terminations of  $-\text{O}$ ,  $-\text{OH}$ , and/or  $-\text{F}$  and multiple water layers.<sup>45,46</sup> No residual peaks of the parent phase are present after etching, indicating a complete MAX-to-MXene conversion. However, peaks corresponding to  $\text{ScF}_3$ , denoted by asterisks, were present. After TBAOH intercalation,  $d_{c/2}$  increases to 24.1 Å [Figure 3g(iii)], reflecting intercalation of the  $\text{TBA}^+$  ions and more water molecules. After filtering of the suspension to form a free-standing film [Figure 3g(iv)],  $d_{c/2}$  is reduced to 20.9 Å presumably because of the removal of some of the water molecules and possibly  $\text{TBA}^+$  ions.

High-resolution X-ray photoelectron spectroscopy (XPS) spectra, with peak fits of a  $\text{d-Nb}_{1.33}\text{CT}_x$  filtered film, are shown in parts a–d of Figure 4 for the Nb 3d, C 1s, O 1s, and F 1s regions, respectively. The peak-fitting results and elemental compositions extracted from the high-resolution spectra can be



**Figure 4.** XPS spectra of the d-Nb<sub>1.33</sub>CT<sub>x</sub> film for the (a) Nb 3d, (b) C 1s, (c) O 1s, and (d) F 1s regions. Color-coded fitting peaks represent various assigned species (Table S4).

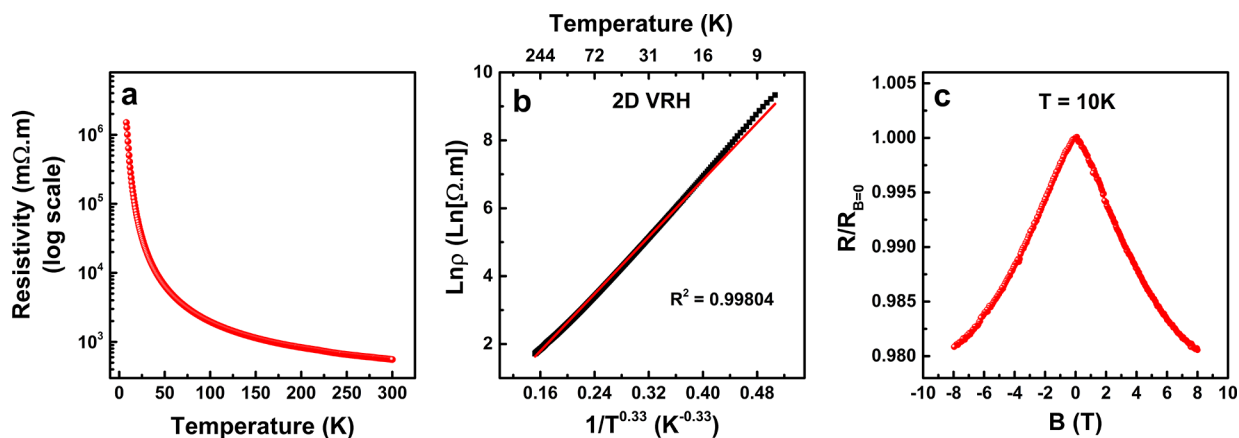
found in the Supporting Information. On the basis of the extracted atomic percentages of Nb, C, O, and F and the fraction of each species solely related to the 2D flakes, the chemical formula that best describes d-Nb<sub>1.33</sub>CT<sub>x</sub> is Nb<sub>1.33</sub>CO<sub>1.7</sub>(OH)<sub>0.6</sub>F<sub>0.2</sub>·0.2H<sub>2</sub>O, while that for d-Nb<sub>2</sub>CT<sub>x</sub> is Nb<sub>2</sub>CO(OH)<sub>0.6</sub>F<sub>0.1</sub>·0.3H<sub>2</sub>O·0.3N. (The C peak associated with MXene was used as the reference with a base error of <±0.1.) The XPS results for d-Nb<sub>2</sub>CT<sub>x</sub> can be found in the Supporting Information. The N component originates from the intercalated TBAOH, a component that was not possible to extract from the d-Nb<sub>1.33</sub>CT<sub>x</sub> flakes because of the overlap between the N 1s and Sc 2p peaks (Figure S3b). It is clear that -O is the dominant termination for both compounds. Interestingly, it is >1.5 times higher in d-Nb<sub>1.33</sub>CT<sub>x</sub> compared to d-Nb<sub>2</sub>CT<sub>x</sub>. The amounts of -OH and -F are comparable in both samples. Note that the fraction of -F surface terminations for both compounds is low, which is common for MXenes treated with TBAOH.<sup>45,46</sup> At 2.5, the total number of termination moles for d-Nb<sub>1.33</sub>CT<sub>x</sub> is 0.5 higher than the theoretical value of 2 obtained when all surface sites are filled.<sup>47</sup> This suggests that

some of the surface terminations may very well reside in the vacancies that result from the removal of Sc atoms and are thus, strictly speaking, no longer terminations. The total moles of terminations for d-Nb<sub>2</sub>CT<sub>x</sub>, excluding N, is 1.7, which is less than 2.

A semilog plot of the resistivity,  $\rho$ , versus temperature,  $T$ , of a 22- $\mu$ m-thick d-Nb<sub>1.33</sub>CT<sub>x</sub> film is shown in Figure 5a. The details of the measurements can be found in the Supporting Information. As the temperature decreases from 300 to 7 K,  $\rho$  increases from 556 to  $1.5 \times 10^6$  m $\Omega$ ·m. To shed more light on the transport mechanism, the  $\rho$  data in the 7–300 K temperature range were fitted to several models, including 2D, 3D, and Efros–Shklovskii (E–S), variable range hopping (VRH), simple thermal activation, and power-law (nonexponential) models. The fitting results (Figures 5b and S5) clearly eliminate the latter two (Figure S5). The same results, however, cannot differentiate between the various VRH models; the  $R^2$  values for the 2D, E–S, and 3D VRH models are comparable, 0.9980, 0.9978, and 0.9964, respectively. Figure 5b plots the results for the most likely model, viz., 2D VRH; the other fits for the other models can be found in Figure S5. Similar behavior has been reported for the other MXene films such as Mo<sub>2</sub>CT<sub>x</sub>,<sup>46</sup> Mo<sub>2</sub>TiC<sub>2</sub>T<sub>x</sub>, and Mo<sub>2</sub>Ti<sub>2</sub>C<sub>3</sub>T<sub>x</sub>.<sup>48</sup>

Magnetoresistance (MR) measurements, performed at 10 K, showed negative MR, which is in contradistinction with the MR measurements on other MXene compounds exhibiting the VRH mechanism.<sup>46,48</sup> However, other disordered materials showing VRH, such as In<sub>2</sub>O<sub>3-x</sub> and Si doped in GaAs have been reported to exhibit negative MR.<sup>49–51</sup> The negative MR for materials having VRH conduction mechanisms has been ascribed to several reasons such as quantum interference, the Zeeman effect, or localized magnetic moments.<sup>52</sup> These comments notwithstanding, much more work, which is beyond the scope of this paper, is needed to obtain a deeper understanding of conduction in our films.

In conclusion, a facile, reproducible, relatively rapid method for producing random vacancies and vacancy clusters in MXenes is presented, where the minority M element in a quaternary solid-solution MAX phase is concomitantly etched with the A-group element. Herein we synthesized (Nb<sub>2/3</sub>Sc<sub>1/3</sub>)<sub>2</sub>AlC and selectively etched both the Sc and Al atoms to produce Nb<sub>1.33</sub>CT<sub>x</sub> with disordered vacancies. The presence of Sc in the quaternary MAX phase decreased the



**Figure 5.** Electronic transport characteristics of the d-Nb<sub>1.33</sub>CT<sub>x</sub> film on temperature and magnetic field: (a) Log of resistivity,  $\rho$ , versus temperature in the 7–300 K temperature range, (b)  $\rho$  versus  $1/T^{1/3}$  in the 7–300 K temperature range assuming 2D VRH conduction model, and (c) MR at 10 K.  $R_{B=0}$  refers to resistance in the absence of a magnetic field.

etching time from 100 to 30 h and increased the yield of delaminated flakes.

When Nb<sub>1.33</sub>CT<sub>x</sub> free-standing films were cooled from 300 to 7 K, their resistivity increased from 556 to 1.5 × 10<sup>6</sup> mΩ·m. The suggested transport mechanism is VRH accompanied by negative MR at 10 K. Last, there is no reason that this approach cannot be used to “dial-in” a controlled number of vacancies, as long as the parent solid-solution MAX phase exists. The fact that the flakes with vacancies are less dense than their counterparts is also noteworthy when specific properties are sought.

## ■ ASSOCIATED CONTENT

### Supporting Information

The Supporting Information is available free of charge on the ACS Publications website at DOI: 10.1021/acsnm.8b00332.

Synthesis of materials, characterization techniques, Rietveld refinement, EDS, electron energy loss spectra, statistical image analysis, XPS spectra, and transport analysis (PDF)

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### Author Contributions

J.H. synthesized the material and performed the XRD, XPS characterization, and analysis. M.P. performed the transport measurements. M.P., E.J.M., and J.H. analyzed the transport data. J.T. performed the SEM and EDX characterization and analyzed the data. J.P. and J.L. performed the STEM characterization and analyzed the data. P.P., M.W.B., and J.R. supervised the research. All authors contributed to the preparation of the manuscript and in discussions. All authors have given approval to the final version of the manuscript.

### Notes

The authors declare no competing financial interest.

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